



RF Power LDMOS Transistor

N-Channel Enhancement-Mode Lateral MOSFET

This 81 W asymmetrical Doherty RF power LDMOS transistor is designed for cellular base station applications requiring very wide instantaneous bandwidth capability covering the frequency range of 1930 to 1990 MHz.

1900 MHz

- Typical Doherty Single-Carrier W-CDMA Performance: $V_{DD} = 30$ Vdc, $I_{DQA} = 540$ mA, $V_{GSB} = 0.6$ Vdc, $P_{out} = 81$ W Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

| Frequency | G_{ps} (dB) | η_D (%) | Output PAR (dB) | ACPR (dBc) |
|-----------|---------------|--------------|-----------------|------------|
| 1930 MHz | 16.2 | 49.6 | 8.1 | -31.0 |
| 1960 MHz | 16.5 | 49.4 | 8.0 | -32.1 |
| 1990 MHz | 16.4 | 49.1 | 7.8 | -32.6 |

Features

- Advanced high performance in-package Doherty
- Designed for wide instantaneous bandwidth applications
- Greater negative gate-source voltage range for improved Class C operation
- Able to withstand extremely high output VSWR and broadband operating conditions
- Designed for digital predistortion error correction systems

A3T19H455W23SR6

1930–1990 MHz, 81 W AVG., 30 V
AIRFAST RF POWER LDMOS
TRANSISTOR



ACP-1230S-4L2S

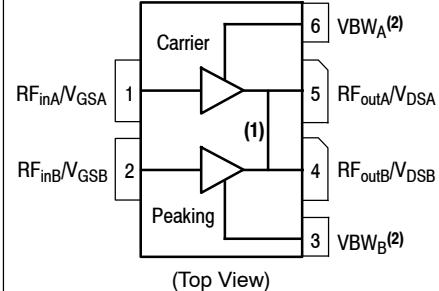


Figure 1. Pin Connections

- Pin connections 4 and 5 are DC coupled and RF independent.
- Device can operate with V_{DD} current supplied through pin 3 and pin 6.

Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|---|-----------|-------------|-----------|
| Drain-Source Voltage | V_{DSS} | -0.5, +65 | Vdc |
| Gate-Source Voltage | V_{GS} | -6.0, +10 | Vdc |
| Operating Voltage | V_{DD} | 32, +0 | Vdc |
| Storage Temperature Range | T_{stg} | -65 to +150 | °C |
| Case Operating Temperature Range | T_C | -40 to +150 | °C |
| Operating Junction Temperature Range (1,2) | T_J | -40 to +225 | °C |
| CW Operation @ $T_C = 25^\circ\text{C}$ when DC current is fed through pin 3 and pin 6 Derate above 25°C | CW | 172 0.7 | W W/°C |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value (2,3) | Unit |
|--|-----------------|-------------|------|
| Thermal Resistance, Junction to Case Case Temperature 81°C, 81 W Avg., W-CDMA, 30 Vdc, $I_{DQA} = 600 \text{ mA}$, $V_{GSP} = 0.6 \text{ Vdc}$, 1960 MHz | $R_{\theta JC}$ | 0.14 | °C/W |

Table 3. ESD Protection Characteristics

| Test Methodology | Class |
|---------------------------------------|-------|
| Human Body Model (per JESD22-A114) | 2 |
| Charge Device Model (per JESD22-C101) | C3 |

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|---|-----------|-----|-----|-----|------|
| Off Characteristics (4) | | | | | |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$) | I_{DSS} | — | — | 10 | μAdc |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 32 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$) | I_{DSS} | — | — | 5 | μAdc |
| Gate-Source Leakage Current ($V_{GS} = 5 \text{ Vdc}$, $V_{DS} = 0 \text{ Vdc}$) | I_{GSS} | — | — | 1 | μAdc |

On Characteristics - Side A, Carrier

| | | | | | |
|--|---------------------|------|------|-----|-----|
| Gate Threshold Voltage ($V_{DS} = 10 \text{ Vdc}$, $I_D = 160 \mu\text{Adc}$) | $V_{GS(\text{th})}$ | 1.4 | 1.8 | 2.2 | Vdc |
| Gate Quiescent Voltage ($V_{DD} = 30 \text{ Vdc}$, $I_{DA} = 540 \text{ mAdc}$, Measured in Functional Test) | $V_{GSA(Q)}$ | 2.2 | 2.6 | 3.0 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10 \text{ Vdc}$, $I_D = 1.6 \text{ Adc}$) | $V_{DS(on)}$ | 0.05 | 0.15 | 0.3 | Vdc |

On Characteristics - Side B, Peaking

| | | | | | |
|---|---------------------|------|------|-----|-----|
| Gate Threshold Voltage ($V_{DS} = 10 \text{ Vdc}$, $I_D = 360 \mu\text{Adc}$) | $V_{GS(\text{th})}$ | 0.8 | 1.2 | 1.6 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10 \text{ Vdc}$, $I_D = 3.6 \text{ Adc}$) | $V_{DS(on)}$ | 0.05 | 0.15 | 0.3 | Vdc |

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.nxp.com/RF/calculators>.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.
4. Side A and Side B are tied together for this measurement.

(continued)

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|---|----------|------|-------|-------|------|
| Functional Tests (1,2,3) (In NXP Doherty Test Fixture, 50 ohm system) $V_{DD} = 30 \text{ Vdc}$, $I_{DQA} = 540 \text{ mA}$, $V_{GSB} = 0.6 \text{ Vdc}$, $P_{out} = 81 \text{ W Avg.}$, $f = 1990 \text{ MHz}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5 \text{ MHz}$ Offset. | | | | | |
| Power Gain | G_{ps} | 15.2 | 16.4 | 17.7 | dB |
| Drain Efficiency | η_D | 46.0 | 49.1 | — | % |
| P_{out} @ 3 dB Compression Point, CW | P3dB | 56.0 | 56.9 | — | dBm |
| Adjacent Channel Power Ratio | ACPR | — | -32.6 | -28.0 | dBc |

Load Mismatch (3) (In NXP Doherty Test Fixture, 50 ohm system) $I_{DQA} = 540 \text{ mA}$, $V_{GSB} = 0.6 \text{ Vdc}$, $f = 1960 \text{ MHz}$, 12 $\mu\text{sec(on)}$, 10% Duty Cycle

| | | | | | |
|--|-----------------------|--|--|--|--|
| VSWR 10:1 at 32 Vdc, 490 W Pulsed CW Output Power (3 dB Input Overdrive from 340 W Pulsed CW Rated Power) | No Device Degradation | | | | |
|--|-----------------------|--|--|--|--|

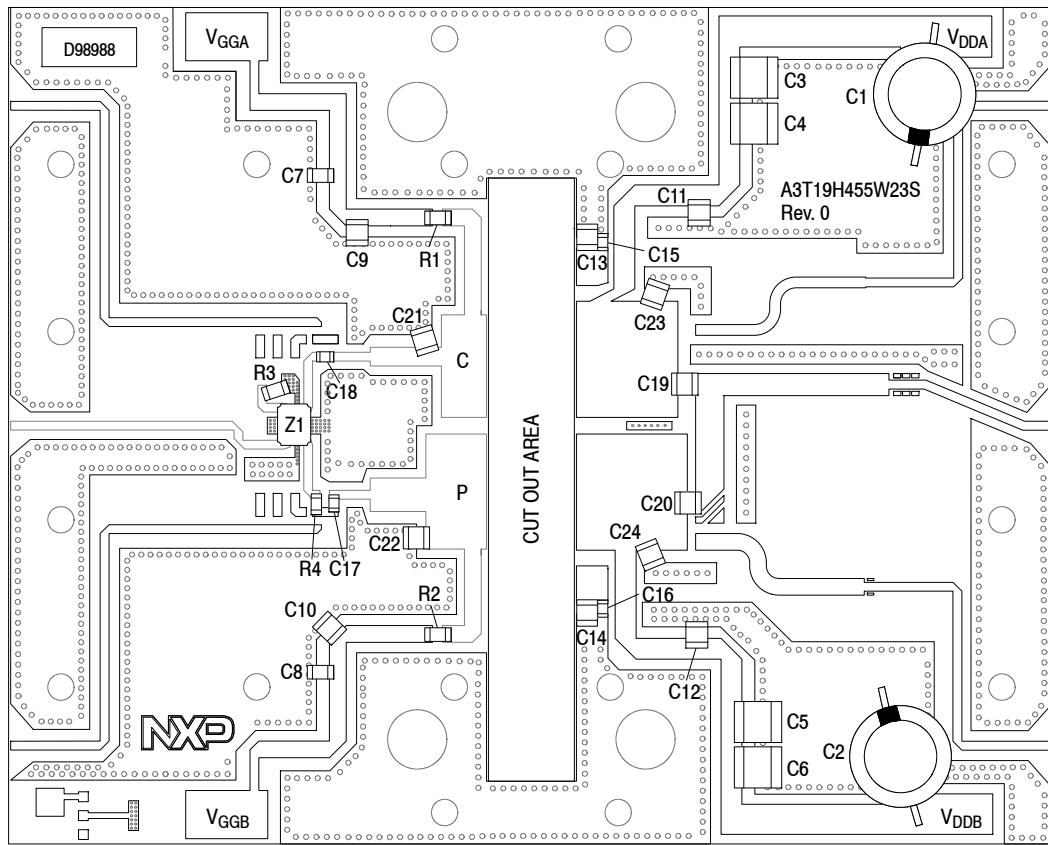
Typical Performance (3) (In NXP Doherty Test Fixture, 50 ohm system) $V_{DD} = 30 \text{ Vdc}$, $I_{DQA} = 540 \text{ mA}$, $V_{GSB} = 0.6 \text{ Vdc}$, 1930–1990 MHz Bandwidth

| | | | | | |
|--|--------------------|---|-------|---|-------|
| P_{out} @ 3 dB Compression Point (4) | P3dB | — | 541 | — | W |
| AM/PM (Maximum value measured at the P3dB compression point across the 1930–1990 MHz bandwidth) | Φ | — | -29 | — | ° |
| VBW Resonance Point (IMD Third Order Intermodulation Inflection Point) | VBW _{res} | — | 200 | — | MHz |
| Gain Flatness in 60 MHz Bandwidth @ $P_{out} = 81 \text{ W Avg.}$ | G_F | — | 0.3 | — | dB |
| Gain Variation over Temperature (-30°C to +85°C) | ΔG | — | 0.009 | — | dB/°C |
| Output Power Variation over Temperature (-30°C to +85°C) | ΔP_{1dB} | — | 0.004 | — | dB/°C |

Table 5. Ordering Information

| Device | Tape and Reel Information | Package |
|-----------------|---|----------------|
| A3T19H455W23SR6 | R6 Suffix = 150 Units, 56 mm Tape Width, 13-inch Reel | ACP-1230S-4L2S |

1. V_{DDA} and V_{DDB} must be tied together and powered by a single DC power supply.
2. Part internally matched both on input and output.
3. Measurements made with device in an asymmetrical Doherty configuration.
4. $P_{3dB} = P_{avg} + 7.0 \text{ dB}$ where P_{avg} is the average output power measured using an unclipped W-CDMA single-carrier input signal where output PAR is compressed to 7.0 dB @ 0.01% probability on CCDF.



Note: V_{DDA} and V_{DBB} must be tied together and powered by a single DC power supply.

Figure 2. A3T19H455W23SR6 Test Circuit Component Layout

Table 6. A3T19H455W23SR6 Test Circuit Component Designations and Values

| Part | Description | Part Number | Manufacturer |
|------------------------|---|----------------------|--------------|
| C1, C2 | 470 μ F, 63 V Electrolytic Capacitor | MCGPR63V477M13X26-RH | Multicomp |
| C3, C4, C5, C6 | 10 μ F Chip Capacitor | C5750X7S2A106M230KB | TDK |
| C7, C8 | 220 nF Chip Capacitor | C1206C224Z5VACTU | Kemet |
| C9, C10, C11, C12, C20 | 10 pF Chip Capacitor | ATC100B100JT500XT | ATC |
| C13, C14 | 10 μ F Chip Capacitor | C3225X7S1H106K | TDK |
| C15, C16, C17 | 10 pF Chip Capacitor | ATC600F100JT250XT | ATC |
| C18 | 8.2 pF Chip Capacitor | ATC600F8R2BT250XT | ATC |
| C19 | 5.1 pF Chip Capacitor | ATC100B5R1CT500XT | ATC |
| C21 | 1.3 pF Chip Capacitor | ATC100B1R3BW500XT | ATC |
| C22, C24 | 0.3 pF Chip Capacitor | ATC100B0R3BT500XT | ATC |
| C23 | 0.2 pF Chip Capacitor | ATC100B0R2BT500XT | ATC |
| R1, R2 | 3.3 Ω , 1/4 W Chip Resistor | WCR1206-3R3F | Welwyn |
| R3 | 50 Ω , 8 W Termination Chip Resistor | C8A50Z4A | Anaren |
| R4 | 0 Ω , 1/4 W Chip Resistor | CWCR08050000Z0EA | Vishay |
| Z1 | 1800-2200 MHz Band, 90°, 2 dB Directional Coupler | X3C20F1-02S | Anaren |
| PCB | Rogers RO4350B, 0.020", $\epsilon_r = 3.66$ | D98988 | MTL |

TYPICAL CHARACTERISTICS — 1930–1990 MHz

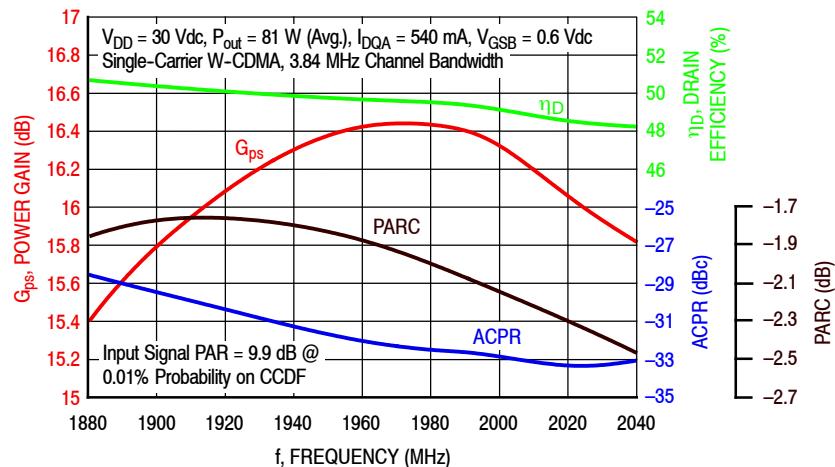


Figure 3. Single-Carrier Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ $P_{out} = 81$ Watts Avg.

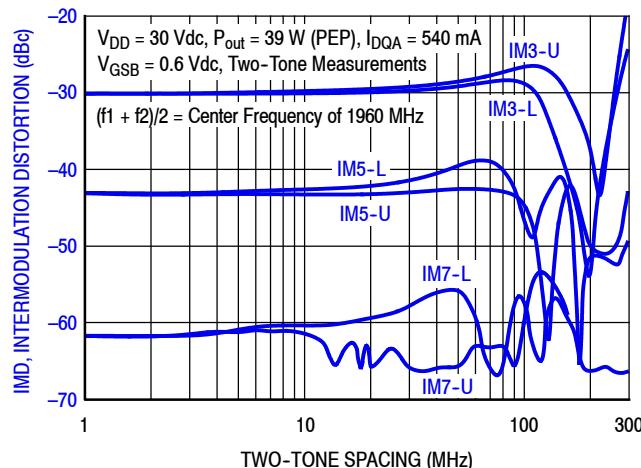


Figure 4. Intermodulation Distortion Products versus Two-Tone Spacing

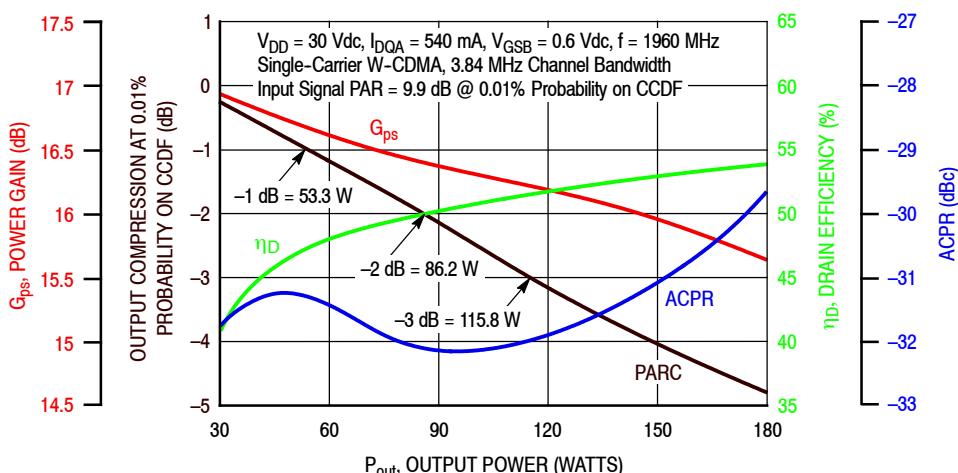


Figure 5. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS — 1930–1990 MHz

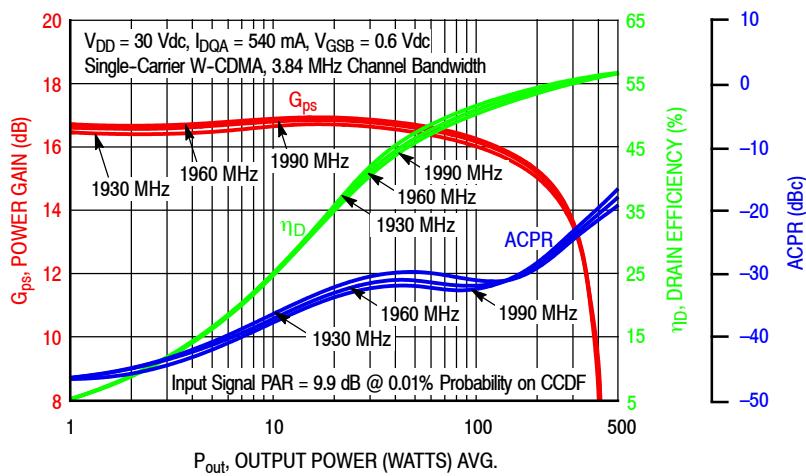


Figure 6. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

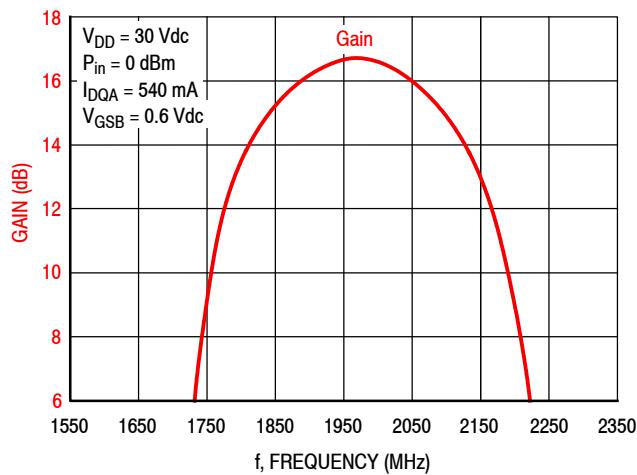


Figure 7. Broadband Frequency Response

Table 7. Carrier Side Load Pull Performance — Maximum Power TuningV_{DD} = 30 Vdc, I_{DQA} = 779 mA, Pulsed CW, 10 μsec(on), 10% Duty Cycle

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Output Power | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P1dB | | | | | |
| | | | Z _{load} ⁽¹⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 3.52 – j7.64 | 3.44 + j7.03 | 1.09 – j4.64 | 18.6 | 52.9 | 194 | 58.8 | -14 |
| 1960 | 4.30 – j7.50 | 4.65 + j7.55 | 1.03 – j4.61 | 18.6 | 52.8 | 191 | 57.7 | -14 |
| 1990 | 5.95 – j8.89 | 6.72 + j7.83 | 1.04 – j4.86 | 18.4 | 52.8 | 190 | 57.2 | -15 |

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Output Power | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P3dB | | | | | |
| | | | Z _{load} ⁽²⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 3.52 – j7.64 | 3.33 + j7.60 | 1.06 – j4.73 | 16.4 | 53.6 | 229 | 59.3 | -20 |
| 1960 | 4.30 – j7.50 | 4.78 + j8.27 | 1.03 – j5.00 | 16.2 | 53.6 | 228 | 57.2 | -19 |
| 1990 | 5.95 – j8.89 | 7.14 + j9.00 | 1.04 – j4.94 | 16.3 | 53.6 | 227 | 58.1 | -21 |

(1) Load impedance for optimum P1dB power.

(2) Load impedance for optimum P3dB power.

Z_{source} = Measured impedance presented to the input of the device at the package reference plane.Z_{in} = Impedance as measured from gate contact to ground.Z_{load} = Measured impedance presented to the output of the device at the package reference plane.**Table 8. Carrier Side Load Pull Performance — Maximum Efficiency Tuning**V_{DD} = 30 Vdc, I_{DQA} = 779 mA, Pulsed CW, 10 μsec(on), 10% Duty Cycle

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Drain Efficiency | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P1dB | | | | | |
| | | | Z _{load} ⁽¹⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 3.52 – j7.64 | 3.49 + j7.36 | 2.43 – j3.71 | 21.5 | 50.9 | 124 | 73.0 | -21 |
| 1960 | 4.30 – j7.50 | 4.78 + j8.04 | 2.32 – j3.40 | 21.8 | 50.5 | 112 | 72.5 | -21 |
| 1990 | 5.95 – j8.89 | 6.95 + j8.48 | 2.19 – j3.23 | 21.9 | 50.1 | 103 | 72.5 | -23 |

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Drain Efficiency | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P3dB | | | | | |
| | | | Z _{load} ⁽²⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 3.52 – j7.64 | 3.46 + j7.73 | 2.66 – j4.05 | 19.3 | 51.6 | 145 | 72.0 | -26 |
| 1960 | 4.30 – j7.50 | 4.88 + j8.52 | 2.50 – j3.81 | 19.5 | 51.4 | 137 | 71.6 | -27 |
| 1990 | 5.95 – j8.89 | 7.08 + j9.14 | 2.07 – j3.99 | 19.1 | 51.9 | 154 | 71.4 | -27 |

(1) Load impedance for optimum P1dB efficiency.

(2) Load impedance for optimum P3dB efficiency.

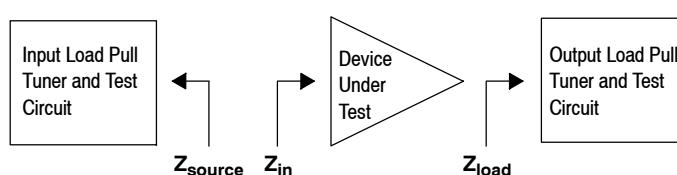
Z_{source} = Measured impedance presented to the input of the device at the package reference plane.Z_{in} = Impedance as measured from gate contact to ground.Z_{load} = Measured impedance presented to the output of the device at the package reference plane.

Table 9. Peaking Side Load Pull Performance — Maximum Power TuningV_{DD} = 30 Vdc, V_{GSB} = 0.6 Vdc, Pulsed CW, 10 μsec(on), 10% Duty Cycle

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Output Power | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P1dB | | | | | |
| | | | Z _{load} ⁽¹⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 2.29 – j6.45 | 1.80 + j5.63 | 2.37 – j5.99 | 13.5 | 56.0 | 400 | 52.9 | -29 |
| 1960 | 3.54 – j6.53 | 2.40 + j6.06 | 2.60 – j5.99 | 13.8 | 56.0 | 399 | 54.1 | -28 |
| 1990 | 4.98 – j6.44 | 3.24 + j6.51 | 2.78 – j5.86 | 13.9 | 55.9 | 392 | 54.2 | -29 |

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Output Power | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P3dB | | | | | |
| | | | Z _{load} ⁽²⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 2.29 – j6.45 | 1.90 + j5.91 | 2.55 – j6.21 | 11.4 | 56.6 | 462 | 53.9 | -35 |
| 1960 | 3.54 – j6.53 | 2.60 + j6.41 | 2.81 – j6.09 | 11.7 | 56.6 | 459 | 54.9 | -35 |
| 1990 | 4.98 – j6.44 | 3.69 + j6.91 | 3.13 – j6.18 | 11.7 | 56.5 | 450 | 54.6 | -34 |

(1) Load impedance for optimum P1dB power.

(2) Load impedance for optimum P3dB power.

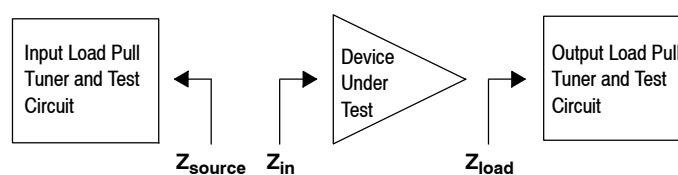
Z_{source} = Measured impedance presented to the input of the device at the package reference plane.Z_{in} = Impedance as measured from gate contact to ground.Z_{load} = Measured impedance presented to the output of the device at the package reference plane.**Table 10. Peaking Side Load Pull Performance — Maximum Efficiency Tuning**V_{DD} = 30 Vdc, V_{GSB} = 0.6 Vdc, Pulsed CW, 10 μsec(on), 10% Duty Cycle

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Drain Efficiency | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P1dB | | | | | |
| | | | Z _{load} ⁽¹⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 2.29 – j6.45 | 1.66 + j5.59 | 3.67 – j4.21 | 14.5 | 55.2 | 328 | 59.4 | -33 |
| 1960 | 3.54 – j6.53 | 2.16 + j5.99 | 3.59 – j3.69 | 14.7 | 54.8 | 301 | 60.3 | -33 |
| 1990 | 4.98 – j6.44 | 2.92 + j6.48 | 3.32 – j3.45 | 14.7 | 54.7 | 298 | 60.4 | -33 |

| f (MHz) | Z _{source} (Ω) | Z _{in} (Ω) | Max Drain Efficiency | | | | | |
|------------|----------------------------|------------------------|---|-----------|-------|-----|-----------------------|--------------|
| | | | P3dB | | | | | |
| | | | Z _{load} ⁽²⁾ (Ω) | Gain (dB) | (dBm) | (W) | η _D (%) | AM/PM (°) |
| 1930 | 2.29 – j6.45 | 1.82 + j5.90 | 3.95 – j4.87 | 12.2 | 56.1 | 403 | 59.5 | -39 |
| 1960 | 3.54 – j6.53 | 2.49 + j6.40 | 4.03 – j4.56 | 12.4 | 55.9 | 393 | 60.1 | -38 |
| 1990 | 4.98 – j6.44 | 3.49 + j6.92 | 3.84 – j4.23 | 12.5 | 55.8 | 384 | 60.1 | -38 |

(1) Load impedance for optimum P1dB efficiency.

(2) Load impedance for optimum P3dB efficiency.

Z_{source} = Measured impedance presented to the input of the device at the package reference plane.Z_{in} = Impedance as measured from gate contact to ground.Z_{load} = Measured impedance presented to the output of the device at the package reference plane.

P1dB – TYPICAL CARRIER SIDE LOAD PULL CONTOURS — 1960 MHz

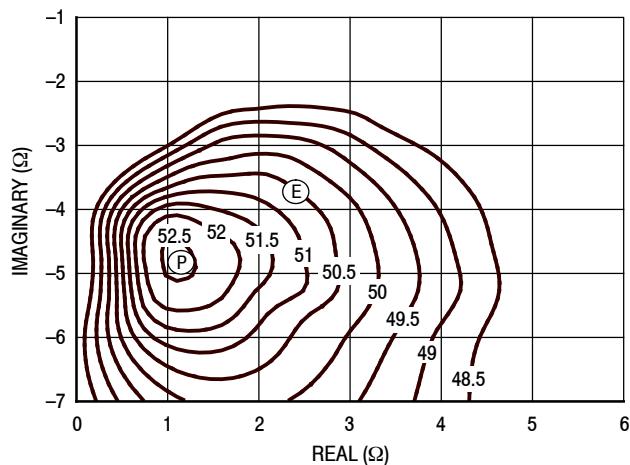


Figure 8. P1dB Load Pull Output Power Contours (dBm)

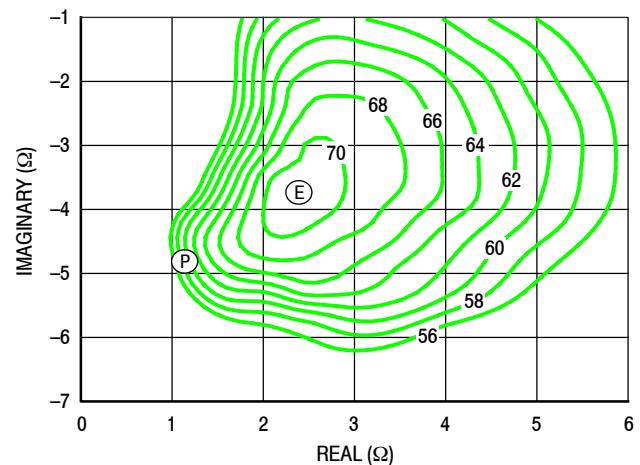


Figure 9. P1dB Load Pull Efficiency Contours (%)

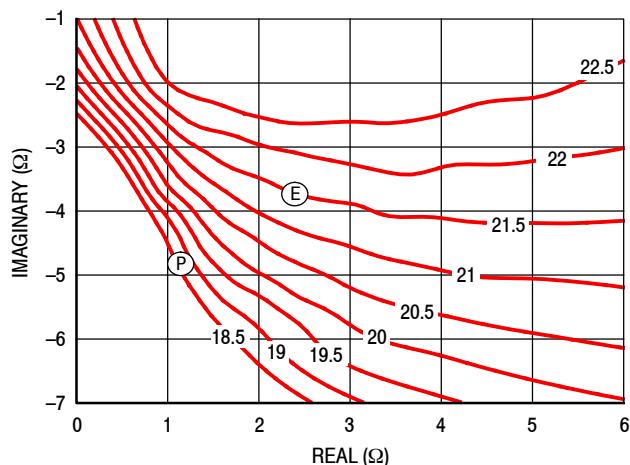


Figure 10. P1dB Load Pull Gain Contours (dB)

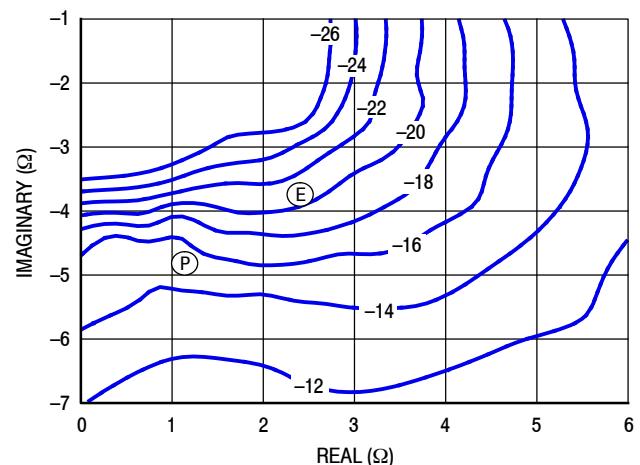


Figure 11. P1dB Load Pull AM/PM Contours (°)

NOTE: (P) = Maximum Output Power

(E) = Maximum Drain Efficiency

- Gain
- Drain Efficiency
- Linearity
- Output Power

P3dB – TYPICAL CARRIER SIDE LOAD PULL CONTOURS — 1960 MHz

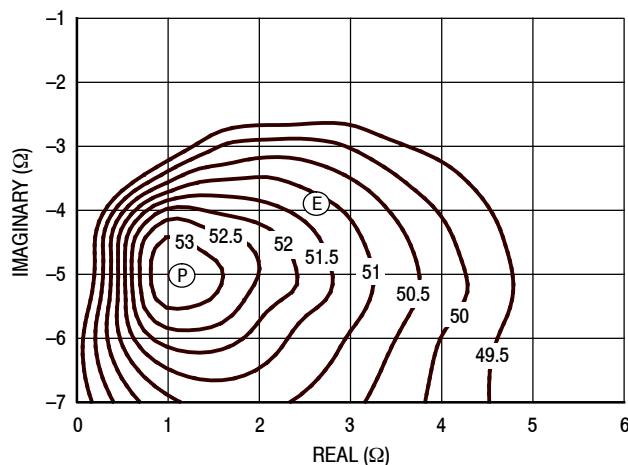


Figure 12. P3dB Load Pull Output Power Contours (dBm)

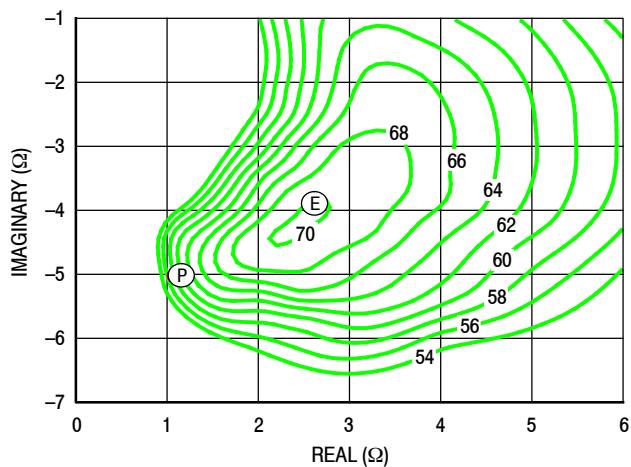


Figure 13. P3dB Load Pull Efficiency Contours (%)

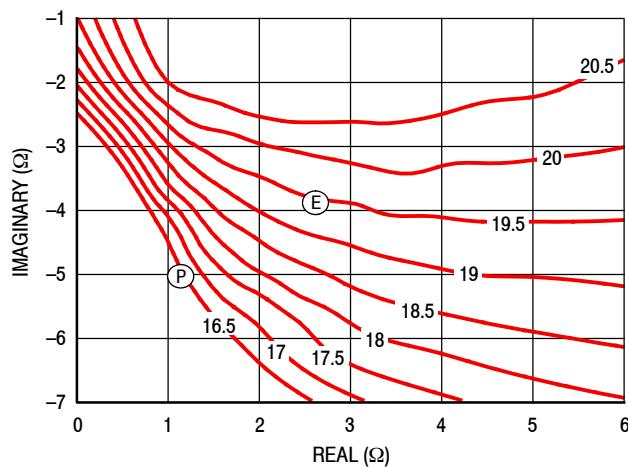


Figure 14. P3dB Load Pull Gain Contours (dB)

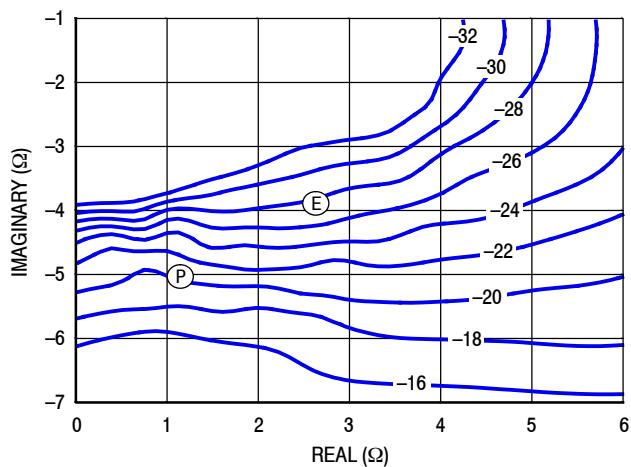


Figure 15. P3dB Load Pull AM/PM Contours (°)

NOTE: (P) = Maximum Output Power

(E) = Maximum Drain Efficiency

- Gain
- Drain Efficiency
- Linearity
- Output Power

P1dB – TYPICAL PEAKING SIDE LOAD PULL CONTOURS — 1960 MHz

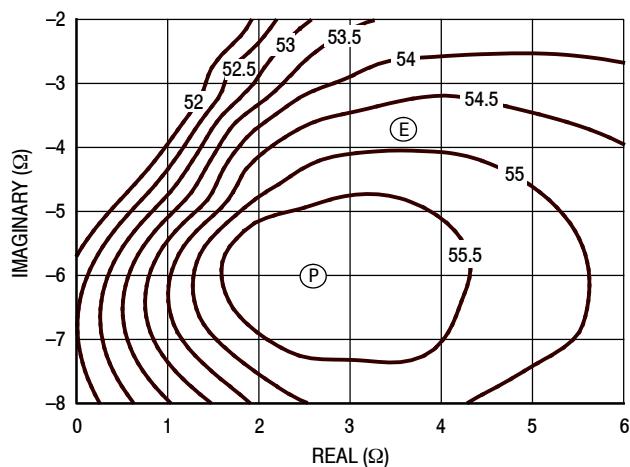


Figure 16. P1dB Load Pull Output Power Contours (dBm)

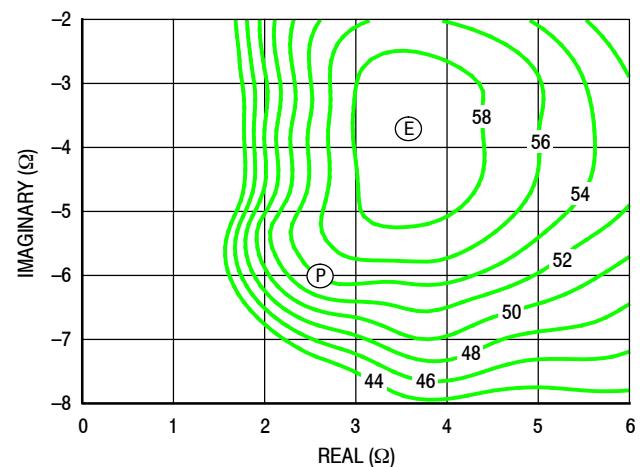


Figure 17. P1dB Load Pull Efficiency Contours (%)

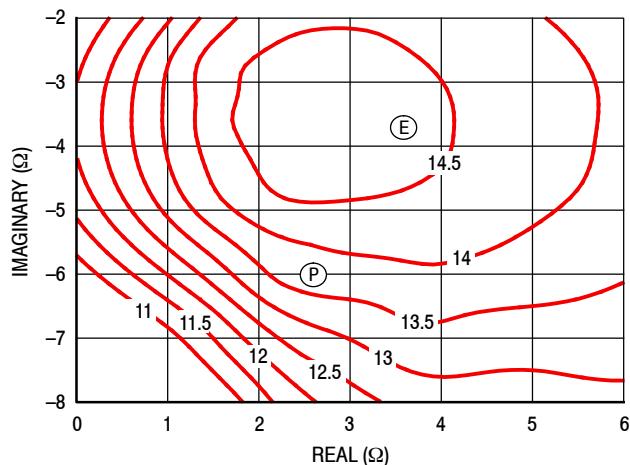


Figure 18. P1dB Load Pull Gain Contours (dB)

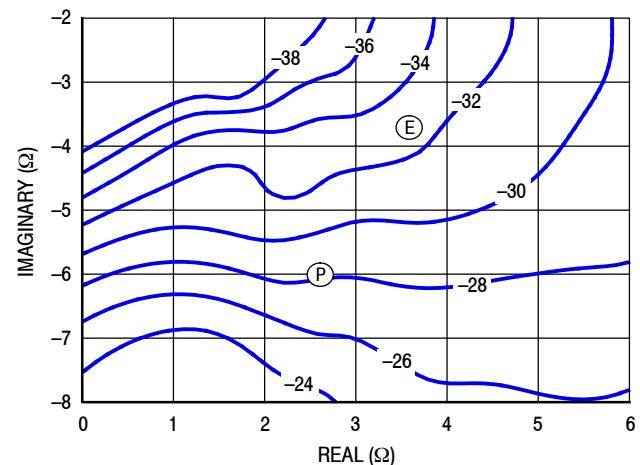


Figure 19. P1dB Load Pull AM/PM Contours (°)

NOTE: (P) = Maximum Output Power

(E) = Maximum Drain Efficiency

- Gain
- Drain Efficiency
- Linearity
- Output Power

P3dB – TYPICAL PEAKING SIDE LOAD PULL CONTOURS — 1960 MHz

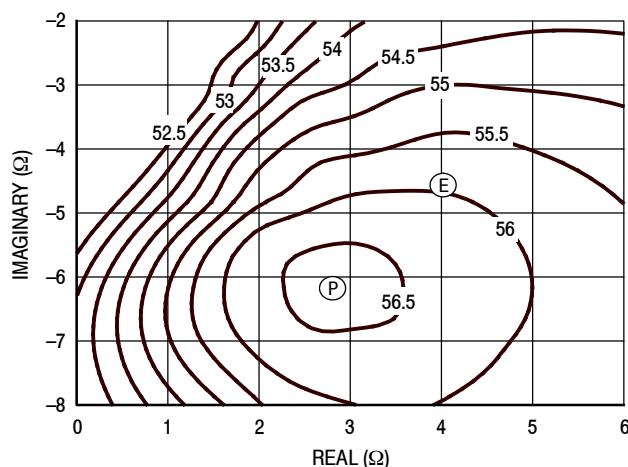


Figure 20. P3dB Load Pull Output Power Contours (dBm)

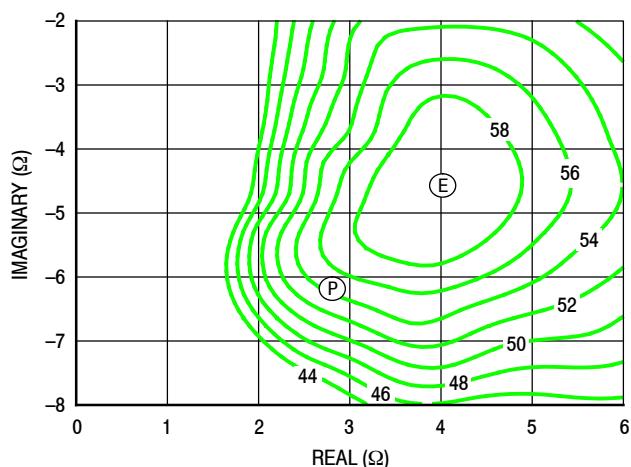


Figure 21. P3dB Load Pull Efficiency Contours (%)

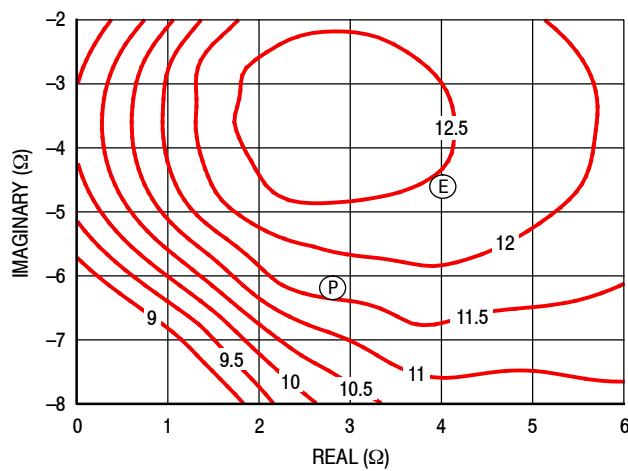


Figure 22. P3dB Load Pull Gain Contours (dB)

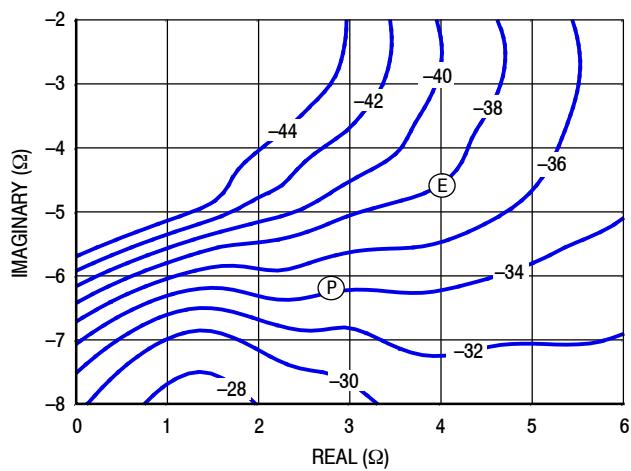


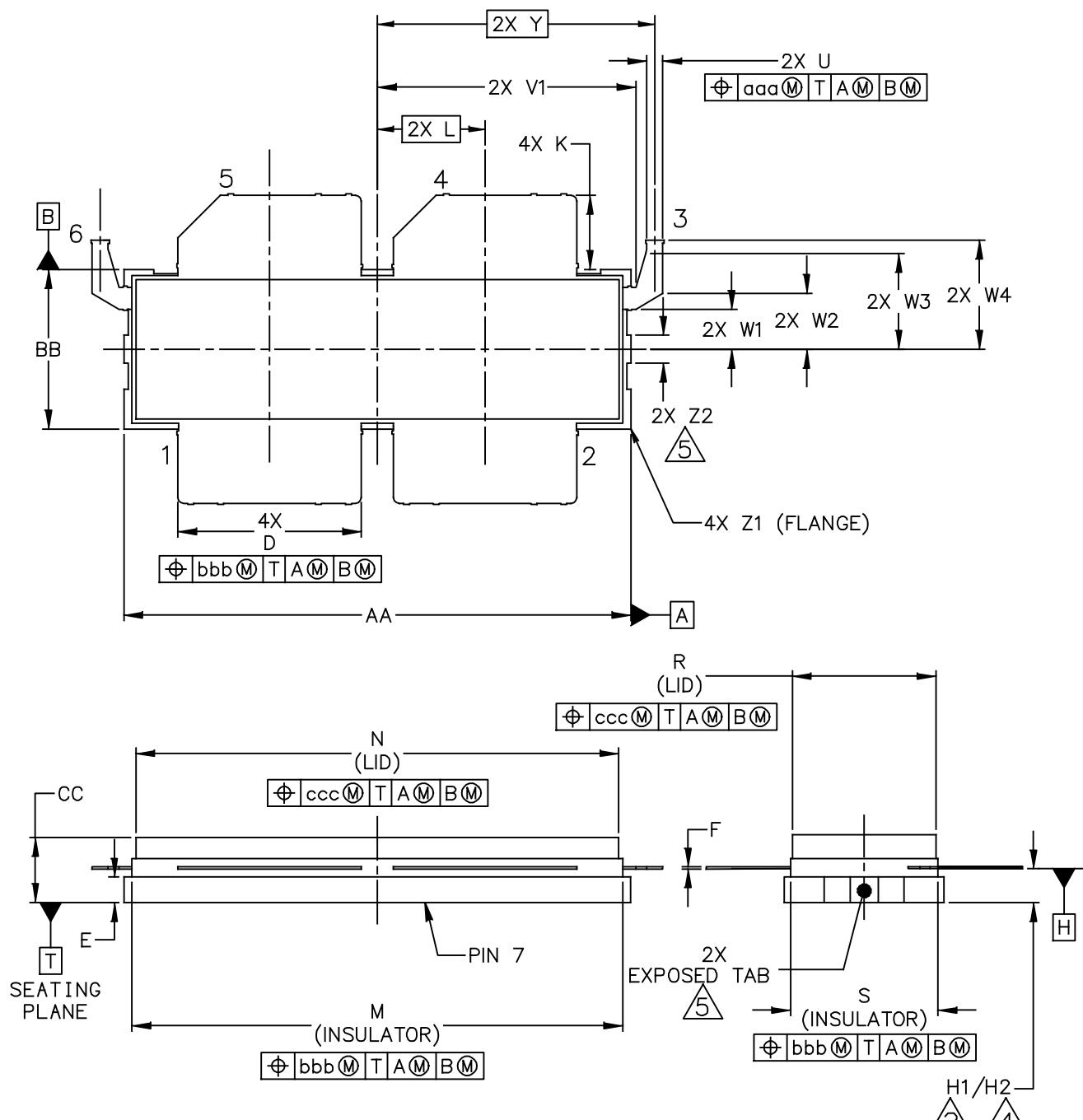
Figure 23. P3dB Load Pull AM/PM Contours (°)

NOTE: (P) = Maximum Output Power

(E) = Maximum Drain Efficiency

- Gain
- Drain Efficiency
- Linearity
- Output Power

PACKAGE DIMENSIONS



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|---|--------------------------|----------------------------|
| TITLE: ACP-1230S-4L2S | DOCUMENT NO: 98ASA00974D | REV: A |
| | STANDARD: NON-JEDEC | |
| | SOT1800-4 | 21 JUN 2017 |

A3T19H455W23SR6

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

2. CONTROLLING DIMENSION: INCH

3. DIMENSIONS H1 AND H2 ARE MEASURED .030 INCH (0.762 MM) AWAY FROM FLANGE PARALLEL TO DATUM B. H1 APPLIES TO PINS 1, 2, 4 & 5. H2 APPLIES TO PINS 3 & 6.

4. TOLERANCE OF DIMENSION H2 IS TENTATIVE.

5. THESE SURFACES OF THE HEAT SLUG ARE NOT PART OF THE SOLDERABLE SURFACES AND MAY REMAIN UNPLATED.

6. DATUM H IS LOCATED AT THE BOTTOM OF THE LEAD FRAME AND IS COINCIDENT WITH THE LEAD WHERE THE LEADS EXIT THE PLASTIC BODY.

7. DIMENSIONS M AND S DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .012 INCH (0.30 MM) PER SIDE. DIMENSIONS M AND S DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.

8. DIMENSIONS D, U AND K DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .010 INCH (0.25 MM) TOTAL IN EXCESS OF THE D, U AND K DIMENSION AT MAXIMUM MATERIAL CONDITION.

9. DATUM A AND B TO BE DETERMINED AT DATUM T.

| DIM | INCHES | | MILLIMETERS | | DIM | INCHES | | MILLIMETERS | |
|-----|-----------|-------|-------------|-------|-----|-----------|-------|-------------|-------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| AA | 1.265 | 1.275 | 32.13 | 32.39 | S | .365 | .375 | 9.27 | 9.53 |
| BB | .395 | .405 | 10.03 | 10.29 | U | .035 | .045 | 0.89 | 1.14 |
| CC | .160 | .190 | 4.06 | 4.83 | V1 | .640 | .655 | 16.26 | 16.64 |
| D | .455 | .465 | 11.56 | 11.81 | W1 | .105 | .115 | 2.67 | 2.92 |
| E | .062 | .069 | 1.57 | 1.75 | W2 | .135 | .145 | 3.43 | 3.68 |
| F | .004 | .007 | 0.10 | 0.18 | W3 | .245 | .255 | 6.22 | 6.48 |
| H1 | .082 | .090 | 2.08 | 2.29 | W4 | .265 | .281 | 6.73 | 7.14 |
| H2 | .078 | .094 | 1.98 | 2.39 | Y | 0.695 BSC | | 17.65 BSC | |
| K | .175 | .195 | 4.45 | 4.95 | Z1 | R.000 | R.040 | R0.00 | R1.02 |
| L | 0.270 BSC | | 6.86 BSC | | Z2 | .060 | .100 | 1.52 | 2.54 |
| M | 1.219 | 1.241 | 30.96 | 31.52 | aaa | .015 | | 0.38 | |
| N | 1.218 | 1.242 | 30.94 | 31.55 | bbb | .010 | | 0.25 | |
| R | .365 | .375 | 9.27 | 9.53 | ccc | .020 | | 0.51 | |

| | | |
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| TITLE: ACP-1230S-4L2S | DOCUMENT NO: 98ASA00974D | REV: A |
| | STANDARD: NON-JEDEC | |
| | SOT1800-4 | 21 JUN 2017 |

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

- Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date | Description |
|----------|-----------|---|
| 0 | Dec. 2017 | <ul style="list-style-type: none">Initial release of data sheet |

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